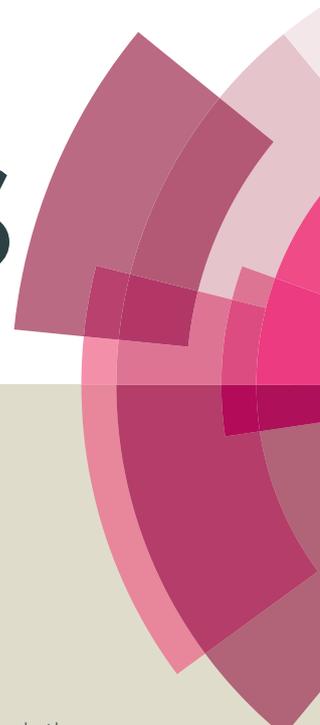


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Advances

ARTICLE

Formaldehyde sensing mechanism of SnO₂ nanowires grown on-chip by sputtering techniques

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Tin dioxide nanowires have been grown by thermal oxidation of sputtered thin films by means of a VLS method. A tin sputtered layer catalyzed by gold nanoparticles, acts as material seed for the localized growth of NWs directly on gas sensor devices, avoiding the manipulation and transport of the nanowires to the electrodes. XRD and HRTEM analysis show that the nanowires crystallize in a rutile structure with a [100] preferential growth direction and are single-crystalline with diameters lower than 50 nm. The response of nanowires to formaldehyde has been compared to thin film based sensors. A sensitivity of 0.10 ppm⁻¹ is reported, twofold the sensitivity of the thin film and short response and recovery times are measured (6 times shorter than thin films). The sensing mechanism proposed for the SnO₂ NWs under formaldehyde exposure is explained by means of conduction measurements and FT-IR analysis. Oxygen species chemisorbed on the surface of each SnO₂ nanowire produce a band bending, which generates a potential barrier (of 0.74 ± 0.02 eV at 300 °C) between the point contact of different nanowires. As evidenced by IR spectroscopy at 300 °C, electrons in the conduction band and in mono-ionized oxygen vacancies (at 0.33 eV below the bottom of the conduction band) are responsible for gas detection.

Introduction

The development of nanomaterials has attracted great interest in recent years due to their distinctive physical properties.¹ More precisely, metal oxide nanowires (MOx NWs) are considered promising materials for their use in several applications such as conductometric solid-state gas sensors. The major advantages of employing nanowires are on one hand, their porous morphology, which increases the surface-to-volume ratio² and could lead to a faster response due to gas diffusion improvement.³ On the other hand, their particular microstructure, free of grain boundaries in the case of single crystalline nanowires, that confer them long-term stability. In this way, a great effort has been carried out in the last decade for developing metal oxide NWs based sensors.^{4,5} However, despite showing promising results regarding sensitivity and response time, they stand at a laboratory research level because the fabrication procedures are not scalable to mass production. In order to have the advantages

of nanomaterials but applicable at commercial level, some works have been focused on developing on-chip nanowire growing procedures.^{6,7} The methods reported in literature are usually based on thermal evaporation and chemical vapour deposition techniques.⁸⁻¹⁰ The source material is a metallic powder placed in an alumina crucible inside a horizontal quartz tube furnace. The powder is evaporated and transported by a carrier gas (mixture of Ar/N₂ with O₂) to the nucleation site. It can be a bare substrate with metal seeds or a patterned substrate provided with electrodes covered with a gold film. In the first case, the nanowires are grown on the whole substrate so additional steps such as collecting and depositing the NWs over the electrodes are required.¹¹ In the second case, the gold film on the substrate serves as nucleation point to grow confined nanowires.^{12,13} The major disadvantage is that crystallinity, shape, length and defects of the nanowires depend on where the substrate is placed.¹⁴ Henceforth, when considering mass production, the flow, temperature profile, reactor geometry and substrate position have to be studied in detail.

Among all the VOCs, formaldehyde (HCHO) is actually considered one of the first priority indoor air pollutants as described in the INDEX project.¹⁵ A significant source of formaldehyde in buildings are adhesives, plastics or pressed-wood products containing formaldehyde resins.¹⁶ Exposure to formaldehyde can cause nasopharyngeal cancer and pulmonary damage even at levels of 6 ppm.¹⁷ As a consequence, the Occupational and Safety Health Administration (OSHA) established a short-term exposure limit

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of 2 ppm and the National Institute for Occupational Safety and Health (NIOSH) states a long-term (30 min.) exposure limit of 0.07 ppm.^{17,18} Thus, taking into account these detection standards, a fast and high sensitive HCHO sensor is required. The lack of commercial sensors that fulfil these requirements (high sensitivity, selectivity, stability and fast response), turns research on formaldehyde gas sensors necessary. It is worth noting that only very recent studies are targeted on HCHO detection by nanomaterials based sensors.^{4,5,19-24} Then, the need for development of an efficient and high sensitive HCHO sensor in a simple and cost-effective way is still present.

In this work, tin dioxide (SnO₂) is selected as sensing material because most of the fundamental work done to explain the sensing mechanism of MO_x gas sensors is developed based on the experimental results obtained with this n-type semiconductor as thick or thin film. In this way, a novel method to grow localized nanowires based on thermal oxidation of sputtered thin films is described. The precursor, the catalyst and the final nanowires are in the same spot. Thus, the NWs are grown on-chip and evenly distributed over the electrodes. Then, formaldehyde detection mechanism is studied in detail, focused on the elucidation of the effect of morphology of the sensing material. With this aim, characterization of the crystallinity and morphology of SnO₂ nanowires and thin films is reported and their sensing characteristics are compared. The method proposed is suitable for growing high sensitive formaldehyde SnO₂ NWs-based gas sensors by sputtering techniques, providing reliable response and mass production capability.

Experimental

Characterization

A Dualbeam field-emission scanning electron microscope (FE-SEM)/ focused ion beam (FIB) system, model Quanta 3D supplied by FEI, was used for analysing the morphology and element composition of the nanowires. Plane-view micrographs were acquired with the FE-SEM using accelerating voltages between 10 and 20 kV. Cross-section views of the prototypes were acquired by FIB milling, to study the element composition using an EDS detector. High resolution HRTEM microscopy, JEOL JEM 2010F (200kV), was employed to analyse the crystalline structure of the nanowires and to determine the growth direction. To carry out the TEM analysis on the nanowires, they were removed from the substrate where they grew by scratching the surface, and were dispersed and transferred to a holey-carbon coated TEM grid.

Absorption IR spectra were carried out on a Perkin-Elmer FT-IR System 2000 spectrophotometer equipped with a Hg-Cd-Tecryo-detector, working in the range of wavenumbers 7200-580 cm⁻¹ at a resolution of 2 cm⁻¹. The sample was placed in a commercial heated stainless steel cell (Aabspec) allowing thermal treatments in situ under vacuum or controlled atmosphere and the simultaneous registration of spectra at temperatures up to 600 °C.

Sensing test & chip fabrication

A complete description of the fabrication process and a scheme of the chip design are included in the Supporting

information (Figure S1). Each sensor is a square with side length 6.35 mm and 0.254 mm thick. They consist of a sensing area of 1 mm and an interspace between Pt electrodes of 50 μm. The gas sensing test set-up is described elsewhere.²³ For these experiments, two certified gas bottles, synthetic air and 100 ppm of HCHO in air, provided by Airliquide ©, were employed to obtain the desired gas mixture inside the chamber (63 cm³).

Results and Discussion

SnO₂ nanowire growth

Tin dioxide NWs are grown based on the well-known Vapour Liquid Solid (VLS) mechanism developed by Wagner and Ellis.²⁵ The majority of SnO₂ NWs grown by this mechanism use thermal evaporation of metallic Sn powder as source material and transport to the nucleation site by a carrier gas.⁸⁻¹¹ A scheme of this process is shown in Fig. S2 (Supporting Information). However, in this work, the Sn material seed and the catalyst are deposited by sputtering in the same spot where the nanowires grow by means of a thermal oxidation process. Fig.1 shows the proposed explanation of the NW growth and the steps carried out during the annealing treatment. Firstly, the sample consisting of a 1μm-thick Sn film and a 5 nm-thick Au film sputtered over an alumina substrate with Pt electrodes (region a) is introduced in the tube furnace. When temperature is increased above the eutectic point of Au-Sn system (~300 °C) in a constant flow of N₂ (400 sccm), Au-Sn liquid alloy nanoparticles are generated (region b). These nanoparticles are supersaturated of Sn, because the Sn film below them acts as a continuous source of Sn atoms that stuck to the alloy. When the temperature of 900 °C is reached, oxygen is introduced in the furnace in a low concentration (6 %). In this moment, the tin present on the Au-Sn liquid particle is oxidized and precipitates producing the growth of the NWs (region c). A continuous diffusion of Sn atoms to the liquid particle and its consequent oxidation produces the final shape of the NWs (region d).

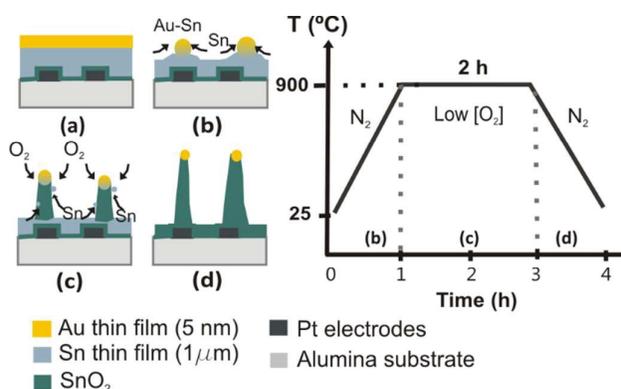


Fig. 1 Nanowire growing process by an annealing treatment of sputtered films at 900°C and oxygen concentration of 6 % over Pt electrodes on alumina substrate.

Different factors can affect the growing process of the NWs, among them oxygen concentration is the most relevant parameter. Fig. 2a is a micrograph of the SnO₂ nanowires grown on alumina substrate at 900°C and under a 6% of

oxygen concentration. An EDS element analysis of the NW sample shows a composition of Sn (67.51 Wt%), O (30.63 Wt%) and Al (1.87 Wt%). If oxygen is not introduced during the annealing process (0% of O₂), the Au-Sn liquid alloy particles solidify when the temperature is decreased. As a consequence, Au-Sn particles with diameters in the range of microns are obtained (Fig. 2b) with an element composition of Au (41.22 Wt%), Sn (54.19 Wt%) and C (4.59 Wt%). In this case C comes from the carbon layer employed to cover non-conducting samples for SEM analysis. On the other hand, if oxygen is introduced in very high concentration (50% of O₂), the oxidation of the Sn film is produced hampering the diffusion of the Sn atoms to the liquid alloy and avoiding the growth of the nanowires (Fig. 2c). The element composition is Sn (57.54 Wt%), O (40.89 Wt%) and Al (1.47 Wt%) and the %Sn/%O ratio is diminished compared to the NWs. This confirms that fully oxidized big SnO₂ clusters are obtained. Fig. 2d corresponds to the surface of a 200 nm-thick SnO₂ thin film deposited by reactive sputtering. It serves to compare the different morphology that can be achieved by only varying the sputtering and thermal annealing process.

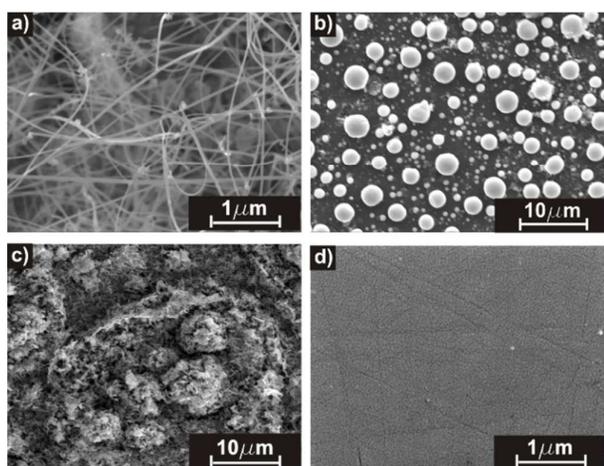


Fig. 2 a) SEM micrograph of samples grown at 900 °C and different oxygen concentrations. a) 6% of O₂. b) 100% of N₂ c) 50% of O₂, d) SnO₂ thin film deposited by reactive sputtering.

The NW growing method can be easily transferred to the fabrication process of a gas sensing device, because only sputtering and annealing treatments are needed. Moreover it allows delimiting the sensing area (where the nanowires grow) by means of a photolithographic process. However, if the Pt-Sn phase diagram is examined,²⁶ it seems that both Pt and Sn could be in a liquid phase at temperatures higher than 770°C. In order to avoid a possible damage of Pt electrodes, a SnO₂ protective layer was introduced before the Sn film deposition. A reactive sputtering in a mixture atmosphere of O₂ and Ar was carried out to deposit a 50-nm thick SnO₂ layer. Then, the oxygen was removed to continue with the deposition of the 1μm-thick Sn layer over the SnO₂ film and finally the 5 nm-thick gold film was deposited. Thus, only the tin film and gold nanoparticles would be melted and oxidized during the annealing process protecting electrodes and assuring good electrical contact. An image of the sample used for the testing measurement is shown in Fig. 3a and a cross section of the sensing device where Pt layer can be distinguished, showing a

continuous and densely-packed film without defects is presented in Fig.3b. Profiles of the elements across the EDS line-scan analysis of the cross section show a well-defined peak corresponding to platinum. It means that the Pt electrodes (200 nm-thick) are not affected by the high temperature annealing process. Moreover, the microstructure of nanowires is not affected by the addition of this SnO₂ thin film as shown in the Supporting Information (Figure S3), where micrographs of the SnO₂ NWs grown on a chip over the Pt electrodes at 900°C under 6% of O₂ for 2 hours are shown.

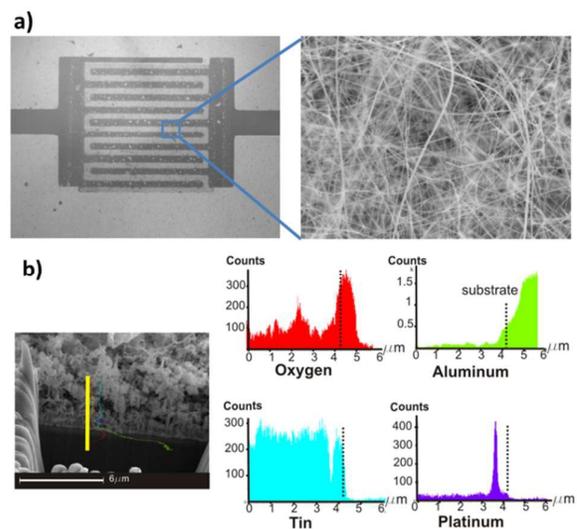


Fig. 3 a) Image of the gas sensing device showing the SnO₂ NWs over the electrodes and b) FIB cross-section of the SnO₂ NWs over Pt electrodes. and EDS line scan analysis of the cross-section.

Thus, this method provides an easy to implement technique suitable for mass production of gas sensing devices. As for example, with our sputtering equipment, 4 wafers of 3"×3" dimensions have been processed at one time. Each wafer consists of 144 chips with dimensions of 6.35×6.35 mm. Thus, with one synthesis process 576 chips were obtained. As the uniformity in the Sn thickness layer is high (thicknesses of 1 μm ± 7% are measured), the concentration and length of the NWs is maintained.

The obtained NWs have been characterized by transmission electron microscopy (TEM). In Fig. 4a, conventional TEM analysis show the morphology of the samples, where some branching and kinking inside the nanowires can be observed. The NWs present different lengths and uniform widths ranging from 30 to 50 nm. In Fig. 4b, high-resolution TEM (HRTEM) images allow to confirm that the nanowires are single crystals, showing clear lattice fringes. Fast Fourier Transformation (FFT) of selected areas in the nanowires show interplanar distances of 4.74 Å, that correspond to (100) and (010) planes, in agreement with the a and b lattice constants of the rutile SnO₂ (P42/mnm 136). Thus, the diffraction pattern can be indexed according to the tetragonal rutile SnO₂ structure (PDF card 41-1145). The analysis indicates that the main growth direction of the nanowires is along [100] direction, in agreement with other studies on the VLS growth of the SnO₂ nanowires.²⁷

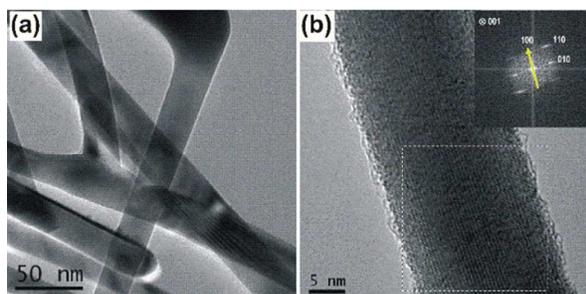
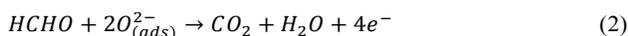
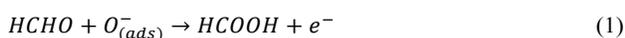


Fig. 4 a) TEM analysis of the SnO₂ NWs b) HRTEM images observed along (001) zone axis. The FFT of the area marked with dotted square is shown as inset.

HCHO sensing properties

To demonstrate the potential application of the in-situ grown SnO₂ NWs, their sensing properties under HCHO atmospheres have been measured. The detection principle is based on the change on resistance of the sensing material when it is exposed to the target gas. For that purpose, the sensing material is heated up to the working temperature, when oxygen adsorption, in the form of negatively charged species, on the surface of the semiconductor is produced. This adsorbed oxygen reacts with HCHO molecules and gives rise to the process of HCHO detection. The electrons released from the reaction of HCHO molecules with adsorbed species (Equation 1 and Equation 2) change the density of charge carriers, and hence the conductance of the sensing material (SnO₂ NWs).²⁸



Sensor response is measured as the ratio of resistance of the sensing material in air and the resistance under the gas to be detected ($\text{SR} = R_0/R_{\text{gas}}$).

In Fig. 5a the sensor response of the samples under 10 ppm of HCHO is presented at different operating temperatures. The maximum response ($\text{SR}=2.45$) is obtained for a temperature of 270 °C. At this temperature, response and recovery times are 1.5 and 2.5 minutes respectively, which are within the time range expected by legislation. A faster response would be expected if the volume of the chamber (63 cm³) was decreased. Fig. 5b shows the transient response under different concentrations of HCHO at the operating temperature of 270 °C. The sensitivity of the sensor, change on sensor response per gas concentration unit ($S = \Delta\text{SR}/\Delta\text{ppm}$), calculated from the slope of the calibration graph is 0.107 ppm⁻¹.²³ The theoretical limit of detection (LOD) calculated from $3\sigma/b$ where σ is the standard deviation of the blank (baseline, response in air) and b the sensitivity, gives a value of LOD: 0.16 ppm assuming a linear range at low concentrations.

In order to evaluate the advantages of the in-situ grown SnO₂ NWs with respect to conventional sputtered films, a sensing device based on a 200 nm-thick SnO₂ film was also tested. A decrease in sensitivity and slower response than in NWs based sensors is obtained, which can be related to the compact morphology of the layer (average grain size of 30 nm). This result puts in evidence that the morphology of the sensing material plays a crucial role on formaldehyde detection. Fig. 6a shows the stability and repeatability of the sensor response tested at 270°C under 5 ppm of HCHO in dry air. A small deviation from the baseline is measured, and the same experiment was repeated once a day during 5 days, resulting in a good stability with a 4% maximum variation. Moreover, the effect of humidity has to be considered when developing sensors for real environment applications. Fig. 6b shows the sensor response where the relative humidity (RH) has been varied in the range 0 to 80 %. A decrease from 2 to 1.42 is measured when RH is raised to normal humidity conditions (40% RH). The interaction of water vapour at temperatures above 200 °C leads to the adsorption of hydroxyl groups. The bonding of these species increases surface conductivity in SnO₂ films which is explained by the following reaction (Equation 3).²⁹

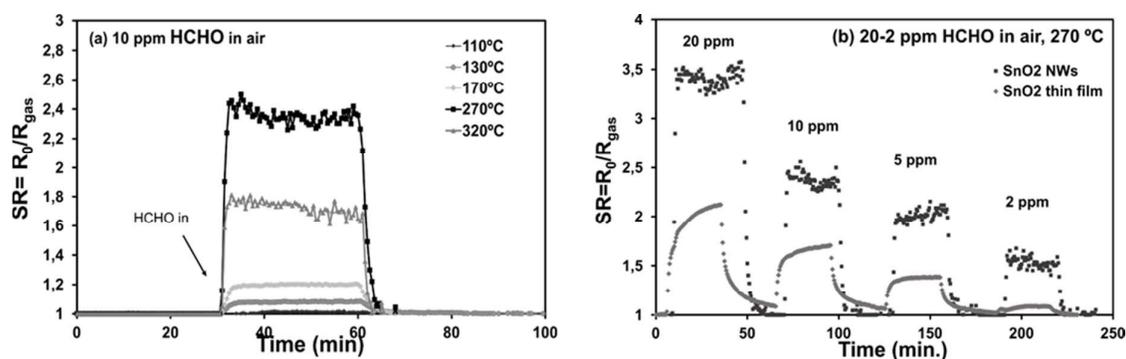
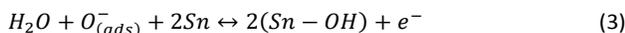


Fig. 5 a) Sensor response at different operating temperatures in dry air. b) Comparison of dynamic response in dry air at 270 °C in a range of 2-20 ppm of SnO₂ nanowires and thin film based sensor.



Hence, a competitive reaction is produced between vapour molecules and HCHO molecules. This causes the decrease in sensor response, because less reactive sites are available for HCHO molecules. Furthermore, selectivity against CO_2 , C_6H_6 and NH_3 has been measured because they are within the major indoor contaminants.¹⁵ The PEL values as reported by OSHA are 1 ppm, 5000 ppm and 50 ppm for CO_2 , C_6H_6 and NH_3 respectively.³⁰ In this work, the response of the prototype to representative concentrations, above their indoor limits, have been selected on purpose. A good cross sensitivity ($Q = \text{SR}_{\text{HCHO}} / \text{SR}_{\text{interferent}}$) of $Q = 1.90, 1.92$ and 1.95 against NH_3 , C_6H_6 and CO_2 respectively is obtained compared to 5 ppm of HCHO (Supporting Information Fig.S4). In order to extend selectivity to other ubiquitous gases like ethanol or acetone, SnO_2 NWs could be doped with NiO. It has been reported in other works that in both NiO- SnO_2 films and nanowires a good selectivity against toluene, ethanol and acetone is obtained.^{11,31}

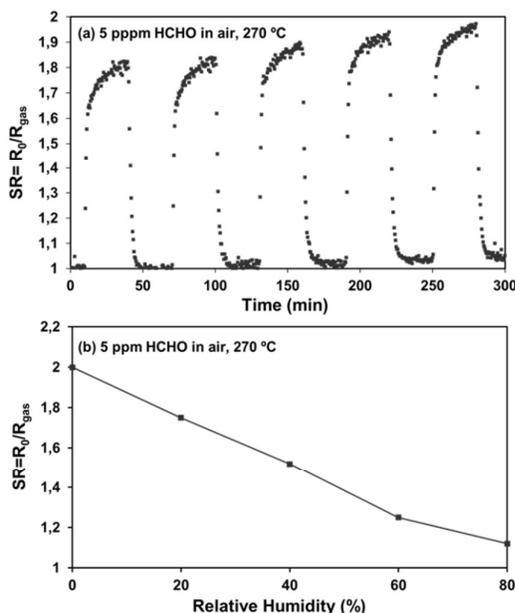


Fig. 6 a) Repeatability measurements under 5 ppm at 270 °C and b) influence of relative humidity on the sensor response of SnO_2 NWs sensors.

With the aim of obtaining a general correlation between gas response and SnO_2 morphology, Table 1 has been included to compare HCHO gas sensing characteristics of different works. It is clear that surface-to-volume ratio and porosity of the sensing material have impact on the sensing response and kinetics. Porous sensing layers based on nanofibers^{11,21} have a higher response than nanoparticle based compact films.³¹⁻³³ This general assumption is consistent with the results from Xu et al.,²⁴ where a sensitivity of 0.58 ppm^{-1} is measured for SnO_2 micro-rods containing meso/macro-pores and decreases to 0.27 ppm^{-1} for thick films consisting in densely packed grains without pores.

Our samples attend to the same principle, as single-crystalline NW array shows better sensing characteristics than polycrystalline compact thin films. These results are in accordance with the gas diffusion/consumption model developed by Iizuka et al. for HCHO detection with SnO_2 porous films.³⁴ In that work, both theoretical and experimental results predict a higher sensor response for films containing micro- and macro-pores than those including only micro-pores. With respect to the response kinetics, the discussion might be focused on studies that test samples with different morphologies but under the same conditions such as volume chamber, gas flow and operating temperature. In the work from Xu et al.²⁴ response time increases from 4.3 seconds in SnO_2 micro-rods to more than 1 minute for densely packed thick films. They suggest that, for a given temperature and in the absence of a catalyst that promotes surface reaction, gas diffusion should be considered the first factor controlling the rate of response. In this way, single-crystalline NW array presents numerous channels for gas transport whereas SnO_2 thin film restricts gas transport to inner particles due to particle agglomeration.

SnO_2 NW sensing mechanism

In order to explain the sensing mechanism of the SnO_2 NWs, the conduction mechanism and the process of oxygen adsorption must be clarified. In the case of this n-type semiconductor, the deviation from stoichiometry (oxygen vacancies) introduces donor levels below the conduction band. For a traditional SnO_2 powder, the donor levels corresponding to first and second ionization energies are situated at 0.03 and 0.15 eV, respectively. First ionization energy is thermally available above 75 °C but the second ionization energy requires a much higher temperature (~ 1500 °C) to excite electrons to the conduction band.^{35,36} This means that in the range of temperatures at which the sensors operate, mono-ionized vacancies are predominant. According to the ionosorption model, at a certain temperature, when oxygen molecules interact with the SnO_2 surface, they pick up electrons from the conduction band and become ionosorbed (or chemisorbed) as described in Equations 4-6.³⁷



Electron transfer from conduction band to chemisorbed species gives rise to a negatively charged surface region. In order to preserve electrical neutrality, a positive space charge layer of width w , also called depletion region, is developed in the surface. This causes a shift in the electrostatic potential and an upward bending (qVs) of the energy bands toward the surface.³⁸ This upward bending generates a potential barrier between point contacts (primarily grain boundaries) that electrons have to overcome during conduction. Thus, the conductance of the sensing material is dependent on the potential barrier and the following relationship serves as a link between surface states (chemisorbed oxygen species) and measured conductance.³⁹

Material form	Deposition Technique	Operating temperature (°C)	Sensitivity (ppm ⁻¹)	Response time (min.)	Recovery time (min.)	Ref.
SnO ₂ NWs	Thermal oxidation PVD	270	0.10	1.5	2.5	This work
SnO ₂ nanoparticle compact film	PVD	270	0.055	8.5	14.5	This work
NiO-doped SnO ₂ NFibers	Electrospinning	200	0.15	0.9	1.3	11
SnO ₂ /In ₂ O ₃ NFibers	Electrospinning	375	0.285	2	2	21
SnO ₂ hierarchical porous micro-rods	Screen printing	320	0.58	0.07 ^a	0.33 ^a	24
SnO ₂ -NiO nanoparticle compact film	Co-precipitation	300	0.055	0.3	1	31
Pd-doped SnO ₂ nanoparticle compact film	Sol-gel	250	0.04	2 ^b	1 ^b	32
Cu-doped SnO ₂ nanoparticle compact film	Co-precipitation	200	0.010	3.5	3	33

Table 1 Sensing characteristics of different SnO₂ based HCHO gas sensors. Response and recovery times are estimated for 10 ppm except in a) calculated for a concentration of 1 ppm and b) 50 ppb.

$$G = G_0 \exp\left(-\frac{eV_s(T)}{k_B T}\right) \quad (7)$$

Where the pre-exponential factor, $G_0 = ge\mu Nd$, is a function of a geometrical factor (g), electronic charge (e), electron mobility (μ) and density of donors (Nd) and k_B is Boltzman's constant. In spite of being temperature-dependent, G_0 is considered a constant because it is not as sensitive to temperature change as the exponential factor.

In the case of SnO₂ NWs this barrier model can be applied to the electron transport between neighboring nanowires, as there is a point contact between them and the thin layer, which assures percolation and barrier crossing. Thus, the conductivity of the nanomaterial is exponentially dependent on the potential barrier which is related to the activation energy of conduction on changing temperature.⁴⁰ In order to evaluate the height of the potential barrier, temperature-stimulated conductance measurements have been carried out. This method, explained in detail in the work from Carotta et al.,⁴¹ consists in evaluating the conductance transient response under a fast temperature change. This data is shown in Fig. S5 in the Supporting Information. Fig. 7 shows the dependence with temperature of the barrier energy measured for SnO₂ NWs in air. Above a transition temperature of 200 °C, also observed in screen printed SnO₂ thick films,⁴¹ the value of the barrier energy increases up to 0.74 ± 0.02 eV at 300 °C. This means that the amount of adsorbed oxygen species is greater above this temperature and as a consequence the sensor response of the material to reducing gases like HCHO might increase. Similar values in the range 0.55-0.7 eV are reported by Malagù et al.,⁴² calculated with the same method for SnO₂ nanoparticles (> 30 nm) obtained via sol-gel route. Moreover, a value of 0.6 ± 0.1 eV is estimated by Kwoka et al.⁴³ by photoemission studies of non-stoichiometric ([O]/[Sn]=1.20) L-CVD deposited SnO₂ films, whereas samples close to stoichiometry ([O]/[Sn]=1.95) correspond to near flat band conditions.

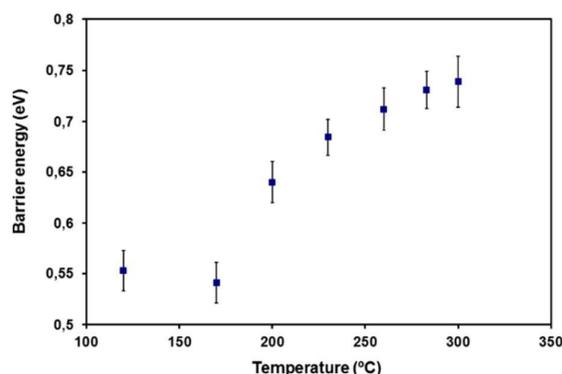


Fig. 7 Energy barrier dependence on temperature in dry air of the SnO₂ NWs calculated by stimulated temperature conductance changes.

Furthermore, to gain deeper insight into the role of oxygen vacancies and chemisorbed oxygen species, FT-IR studies of the sensing material have been performed. It allows following the electrical absorption variations induced by gaseous environment change. In this way, it is possible to put in evidence the injection of electrons in the material during the interaction with formaldehyde. For this analysis, SnO₂ NWs have been grown on silicon substrate that allows spectra recording in transmission mode. The synthesis process is the same followed for the device fabrication on alumina substrate and the same microstructural properties are obtained. The sample is preventively treated at 550 °C in dry oxygen to let oxygen species adsorb on the surface of the semiconductor following Equation 4 to Equation 6. Then, the interaction with 20 mbar of pure formaldehyde at temperatures in the range 100-350 °C with increasing steps of 50 °C is studied. In this second stage, reactions of HCHO with adsorbed species are produced as described in Equation 1 and Equation 2. It is important to point out that FT-IR spectra are reported as difference spectra, where the subtrahend spectrum is always

that of the oxidised sample (after treatment at 550 °C) recorded in O₂ at the same temperature as in formaldehyde. Examples of the spectra in O₂ and in HCHO are shown in the Supporting Information (Fig. S6). This operation allows putting in evidence sample modification induced by formaldehyde interaction and allows avoiding baseline changes arising from temperature increase.

In Fig. 8 difference spectra of SnO₂ nanowires after interaction with formaldehyde at increasing temperature are reported. Up to 250 °C, no modifications induced by formaldehyde are observed. Only roto-vibrational modes of formaldehyde in the gas phase are evidenced. Starting from 300 °C, very broad absorption, extended from 1000 to 5000 cm⁻¹ starts to develop and increases in intensity on increasing temperature. This broad absorption is centered at about 2700 cm⁻¹ which corresponds to energy of 0.33 eV. As known, oxygen vacancies are the predominant intrinsic defects in SnO₂ crystals and powders in the range of temperatures in which our samples have been prepared.⁴⁴ Thus, this absorption is related to the electronic transition from the energy level of oxygen vacancies to the conduction band. It can be assigned as the second ionization energy of oxygen vacancies, which in traditional nano-structured SnO₂ powder appears at 1200 cm⁻¹ (at a lower energy of 0.15 eV).^{38,44} First ionization energy of oxygen vacancies (0.03 eV) allows the thermal excitation of electrons in the conduction band already at room temperature and it is not detectable in the medium IR region.

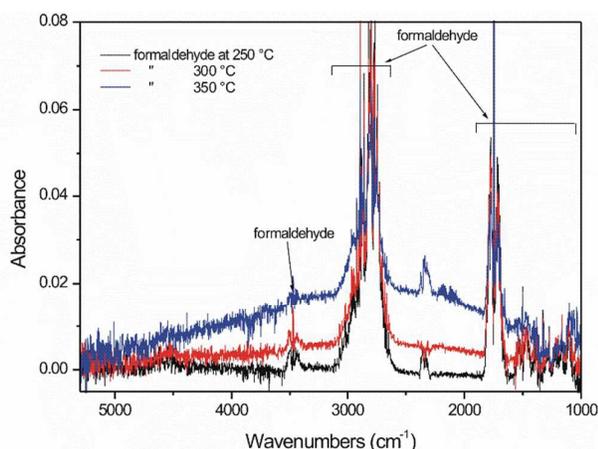


Fig. 8 FT-IR difference spectra of SnO₂ NWs in interaction with 20 mbar of HCHO at 250 °C (black line), 300 °C (red line) and 350 °C (blue line).

In accordance with the obtained results, a model of the sensing mechanism for the in-situ grown SnO₂ NWs is proposed. Oxygen adsorption is produced by two different paths: one involves conduction band electrons, which influences band bending and electrical conductivity, and the second, evidenced in the FT-IR analysis, is associated to electrons trapped in mono-ionized oxygen vacancies. Regarding the first path, morphology of the nanowires is decisive because electron conduction is limited by the presence of potential barriers between point contacts. Henceforth, in the case of our single-crystal SnO₂ NWs, as they are free of grain boundaries, each nanowire acts as a

conduction channel where electrons move freely. The very thin layer (50 nm) deposited over the Pt electrodes serves as a buffer layer that puts into contact different nanowires and drives the electrons to the electrode.⁴⁵ These electrons must overcome a potential barrier generated in the point contacts of adjacent NWs or passing through the NW to the buffer layer as shown in Fig. 9a. The height of this potential barrier depends on temperature, as it is related to oxygen ionosorption mechanism which gives rise to gas detection. A good ohmic contact between sensing material and Pt electrodes is verified by I-V curves of the samples (Supporting Information Fig.S7) measured in two probe mode. A linear behaviour with the applied voltage (-5 to +5 V) throughout the entire temperature range (200-300 °C) is obtained.⁴⁶

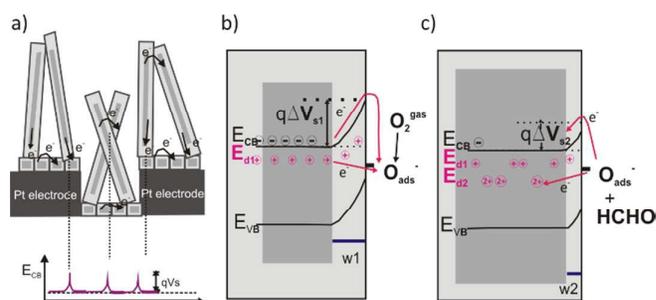


Fig. 9 a) Electron conduction mechanism of single-crystal SnO₂ NW array sensors over Pt electrodes including the buffer layer. b) Oxygen adsorption on n-type SnO₂ NW producing band bending ($q\Delta V_{s1}$) and bi-ionized oxygen vacancies. c) Reaction of formaldehyde with chemisorbed oxygen species transferring electrons to the oxygen vacancies and conduction band.

On the other hand, Fig. 9b shows the energy band diagram of the n-type semiconductor considering two paths for oxygen ionosorption. As revealed in the FT-IR analysis, a transfer of electrons from mono-ionized oxygen vacancies (V_o^+) to oxygen species is produced, generating bi-ionized oxygen vacancies (V_o^{2+}). This is described in the band diagram by the formation of new donor levels below the conduction band (E_{d2}). During the interaction with formaldehyde (Fig. 9c), HCHO molecules react with adsorbed oxygen species (Equation 1 and 2), and electrons are released. These electrons replenish the conduction band and the potential barrier decreases (from qV_{s1} to qV_{s2}) giving rise to a smaller depletion region $w_2 < w_1$ (Fig. 9c). As evidenced in IR spectra, electrons also re-populate oxygen vacancies in a significant way at 300 °C. Thus, bi-ionized oxygen vacancies (V_o^{2+}) are populated by the released electrons and mono-ionized oxygen vacancies (V_o^+) are created. In this way, the broad absorption centered at 2700 cm⁻¹ can be related to the photo-ionization of V_o^+ by the incident IR radiation ($V_o^+ + h\nu \rightarrow V_o^{2+} + e^-$ (CB)). This broad absorption in the difference spectra validates the fact that HCHO re-populates V_o^{2+} creating new V_o^+ for photo-ionization, otherwise the spectra in O₂ and in HCHO would be the same.

Conclusions

The present study has successfully demonstrated the fabrication of SnO₂ NWs based prototypes by a low cost method suitable for mass production. The SnO₂ NWs are grown in-situ over platinum electrodes by thermal oxidation of sputtered thin films. These nanowires are single crystals, with diameters smaller than 50 nm and a preferential [100] growth direction.

The NWs based sensing devices have been tested under HCHO concentrations in the range 2–20 ppm. Moreover, their sensing characteristics have been compared to SnO₂ thin films gas sensors, to put in evidence the influence of morphology on the detection mechanism of HCHO. Nanowires present higher sensitivity at the operating temperature of 270 °C and shorter response and recovery times.

A sensing mechanism is proposed for these in-situ grown SnO₂ NWs, which establishes a relation between conductance and surface states (oxygen chemisorbed species). Oxygen species are adsorbed as they pick-up electrons from the conduction band generating a potential barrier, that increases above 200 °C. On the other hand, at 300 °C also mono-ionized oxygen vacancies play a role on oxygen adsorption. At this temperature, HCHO interacts with chemisorbed oxygen species in a significant way, re-populating bi-ionized oxygen vacancies and replenishing the conduction band. This result may explain the high response of the nanowires at 270 °C. This work opens up a new window for the development of reliable and low cost nanomaterials based gas sensors.

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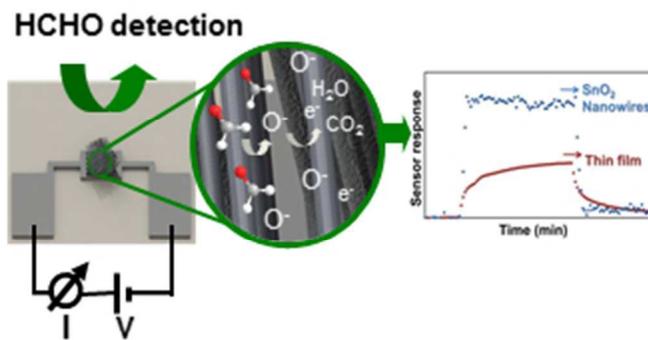
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